

SWITCHING  
 N-CHANNEL POWER MOS FET

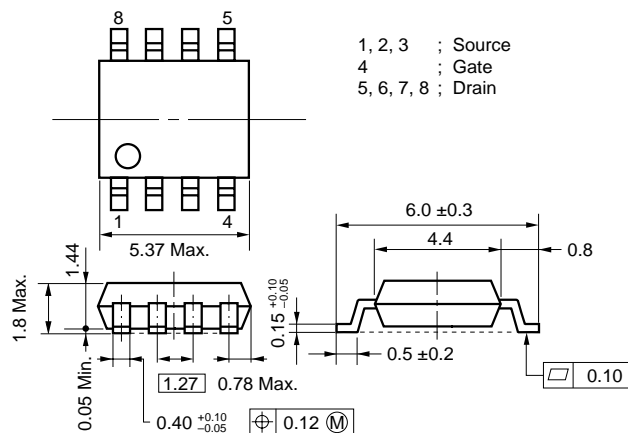
DESCRIPTION

The  $\mu$ PA1727 is N-Channel MOS Field Effect Transistor designed for high current switching applications.

FEATURES

- Single chip type
- Low on-state resistance  
 $R_{DS(on)1} = 14 \text{ m}\Omega$  TYP. ( $V_{GS} = 10 \text{ V}$ ,  $I_D = 5.0 \text{ A}$ )  
 $R_{DS(on)2} = 17 \text{ m}\Omega$  TYP. ( $V_{GS} = 4.5 \text{ V}$ ,  $I_D = 5.0 \text{ A}$ )  
 $R_{DS(on)3} = 19 \text{ m}\Omega$  TYP. ( $V_{GS} = 4.0 \text{ V}$ ,  $I_D = 5.0 \text{ A}$ )
- Low  $C_{iss}$ :  $C_{iss} = 2400 \text{ pF}$  TYP.
- Built-in G-S protection diode
- Small and surface mount package (Power SOP8)

PACKAGE DRAWING (Unit: mm)



★ ORDERING INFORMATION

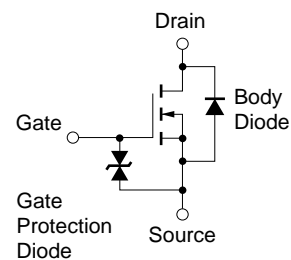
PART NUMBER	PACKAGE
$\mu$ PA1727G	Power SOP8

ABSOLUTE MAXIMUM RATINGS ( $T_A = 25^\circ\text{C}$ , All terminals are connected.)

Drain to Source Voltage ( $V_{GS} = 0 \text{ V}$ )	$V_{BSS}$	60	V
Gate to Source Voltage ( $V_{DS} = 0 \text{ V}$ )	$V_{GSS}$	$\pm 20$	V
Drain Current (DC)	$I_{D(DC)}$	$\pm 10$	A
Drain Current (Pulse) <sup>Note1</sup>	$I_{D(pulse)}$	$\pm 40$	A
Total Power Dissipation ( $T_A = 25^\circ\text{C}$ ) <sup>Note2</sup>	$P_T$	2.0	W
Channel Temperature	$T_{ch}$	150	$^\circ\text{C}$
Storage Temperature	$T_{stg}$	-55 to +150	$^\circ\text{C}$
Single Avalanche Current <sup>Note3</sup>	$I_{AS}$	10	A
Single Avalanche Energy <sup>Note3</sup>	$E_{AS}$	200	mJ

- Notes 1.  $PW \leq 10 \mu\text{s}$ , Duty Cycle  $\leq 1\%$   
 2. Mounted on ceramic substrate of  $1200 \text{ mm}^2 \times 2.2 \text{ mm}$   
 3. Starting  $T_{ch} = 25^\circ\text{C}$ ,  $V_{DD} = 30 \text{ V}$ ,  $R_G = 25 \Omega$ ,  $V_{GS} = 20 \rightarrow 0 \text{ V}$

EQUIVALENT CIRCUIT



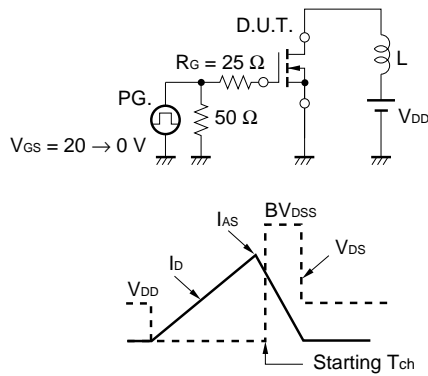
Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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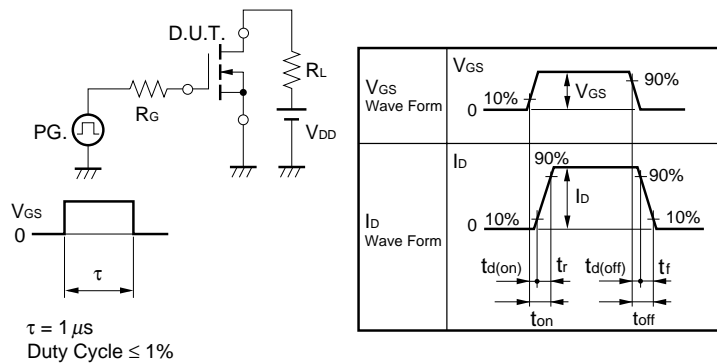
**ELECTRICAL CHARACTERISTICS (TA = 25°C, All terminals are connected.)**

CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = 60\text{ V}, V_{GS} = 0\text{ V}$			10	μA
Gate Leakage Current	$I_{GSS}$	$V_{GS} = \pm 20\text{ V}, V_{DS} = 0\text{ V}$			±10	μA
Gate Cut-off Voltage	$V_{GS(off)}$	$V_{DS} = 10\text{ V}, I_D = 1\text{ mA}$	1.5	2.0	2.5	V
Forward Transfer Admittance	$ y_{fs} $	$V_{DS} = 10\text{ V}, I_D = 5.0\text{ A}$	8.0	14		S
Drain to Source On-state Resistance	$R_{DS(on)1}$	$V_{GS} = 10\text{ V}, I_D = 5.0\text{ A}$		14	19	mΩ
	$R_{DS(on)2}$	$V_{GS} = 4.5\text{ V}, I_D = 5.0\text{ A}$		17	22	mΩ
	$R_{DS(on)3}$	$V_{GS} = 4.0\text{ V}, I_D = 5.0\text{ A}$		19	25	mΩ
Input Capacitance	$C_{iss}$	$V_{DS} = 10\text{ V}$		2400		pF
Output Capacitance	$C_{oss}$	$V_{GS} = 0\text{ V}$		400		pF
Reverse Transfer Capacitance	$C_{rss}$	$f = 1\text{ MHz}$		200		pF
Turn-on Delay Time	$t_{d(on)}$	$V_{DD} = 30\text{ V}, I_D = 5.0\text{ A}$		24		ns
Rise Time	$t_r$	$V_{GS} = 10\text{ V}$		120		ns
Turn-off Delay Time	$t_{d(off)}$	$R_G = 10\ \Omega$		120		ns
Fall Time	$t_f$			70		ns
Total Gate Charge	$Q_G$	$V_{DD} = 48\text{ V}$		45		nC
Gate to Source Charge	$Q_{GS}$	$V_{GS} = 10\text{ V}$		6		nC
Gate to Drain Charge	$Q_{GD}$	$I_D = 10\text{ A}$		13		nC
Body Diode Forward Voltage	$V_{F(S-D)}$	$I_F = 10\text{ A}, V_{GS} = 0\text{ V}$		0.8		V
Reverse Recovery Time	$t_{rr}$	$I_F = 10\text{ A}, V_{GS} = 0\text{ V}$		45		ns
Reverse Recovery Charge	$Q_{rr}$	$di/dt = 100\text{ A}/\mu\text{s}$		84		nC

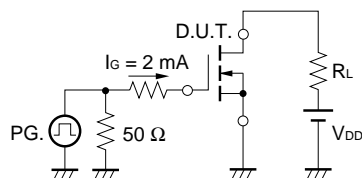
**TEST CIRCUIT 1 AVALANCHE CAPABILITY**



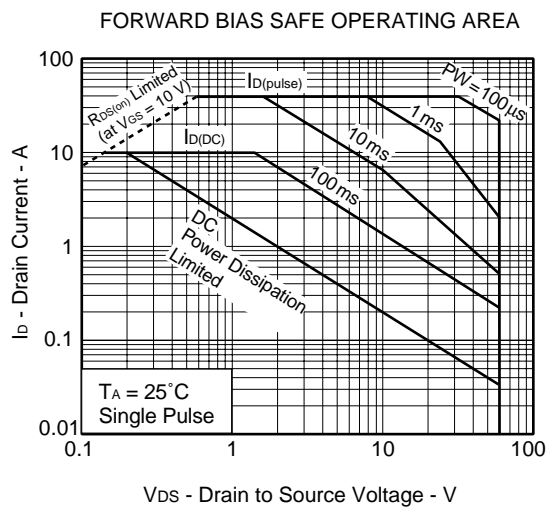
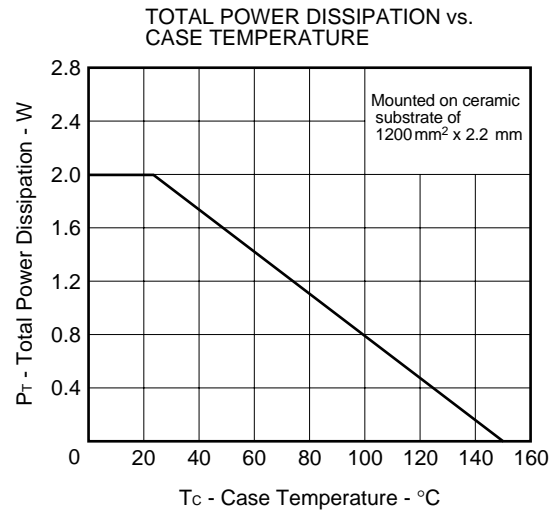
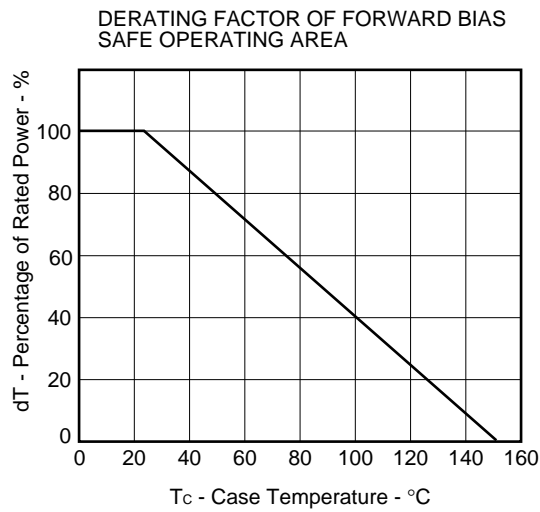
**TEST CIRCUIT 2 SWITCHING TIME**



**TEST CIRCUIT 3 GATE CHARGE**



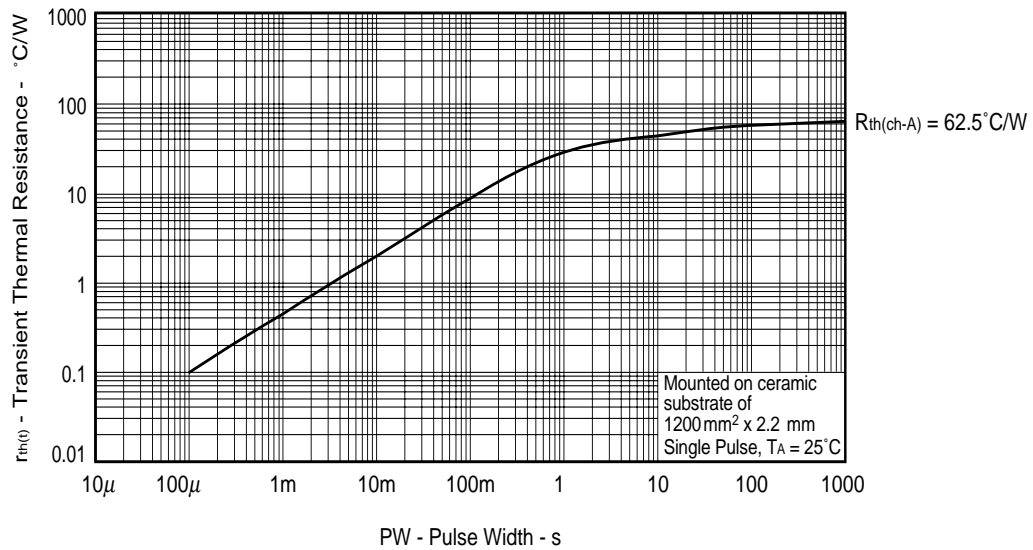
TYPICAL CHARACTERISTICS (T<sub>A</sub> = 25°C, All terminals are connected.)



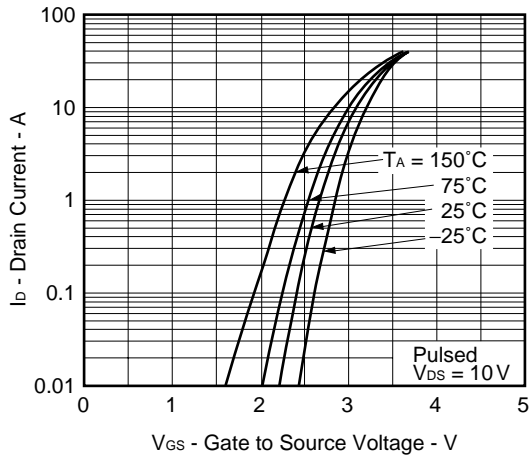
Remark

Mounted on ceramic substrate of 1200 mm<sup>2</sup> x 2.2 mm

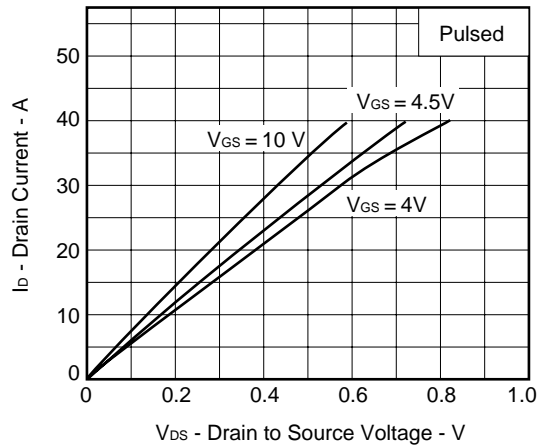
TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH



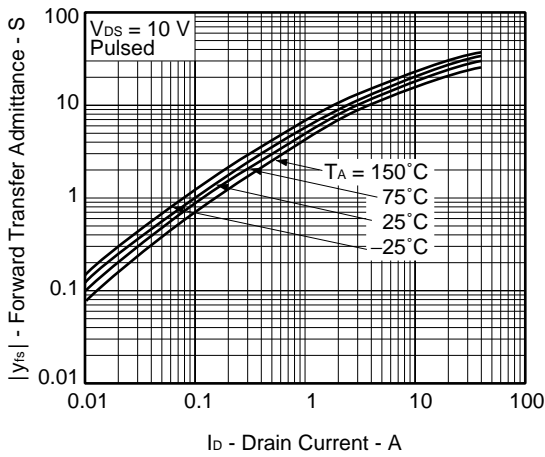
FORWARD TRANSFER CHARACTERISTICS



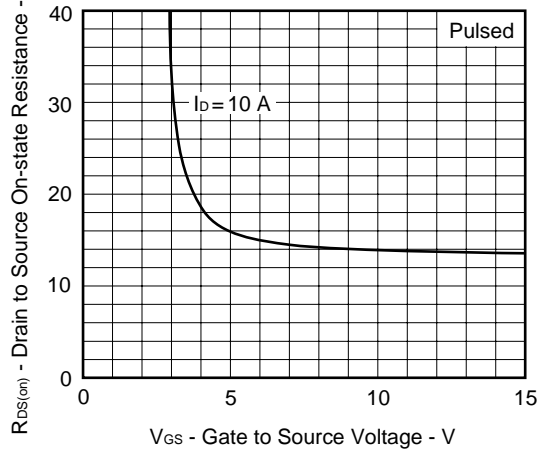
DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE



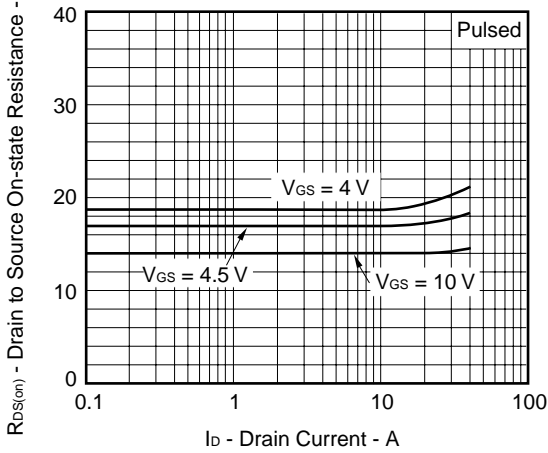
FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



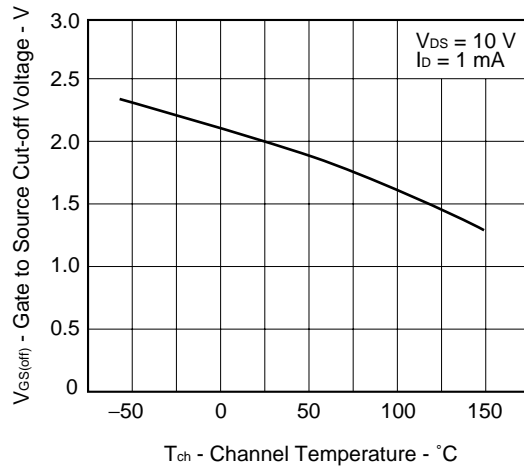
DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE

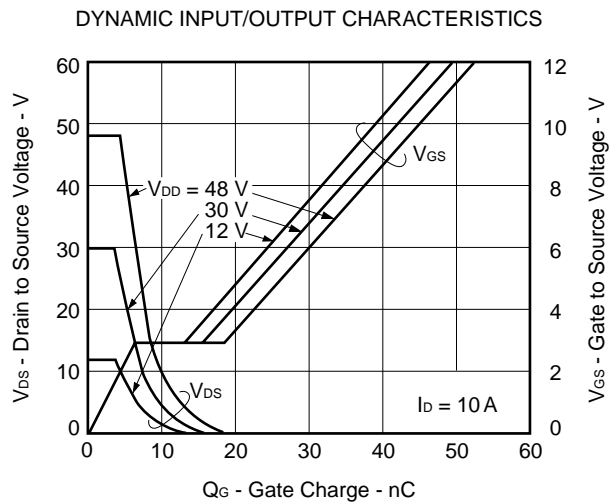
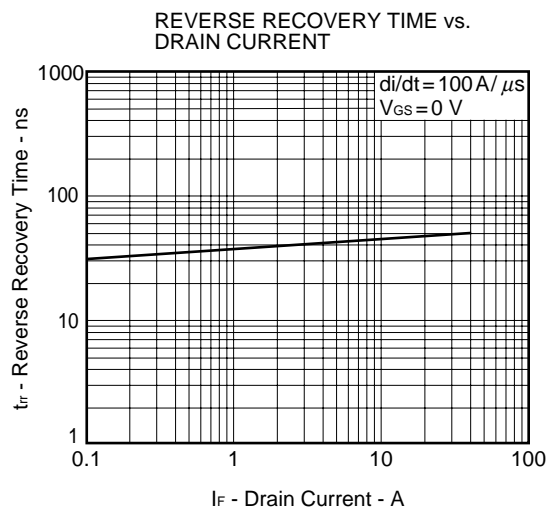
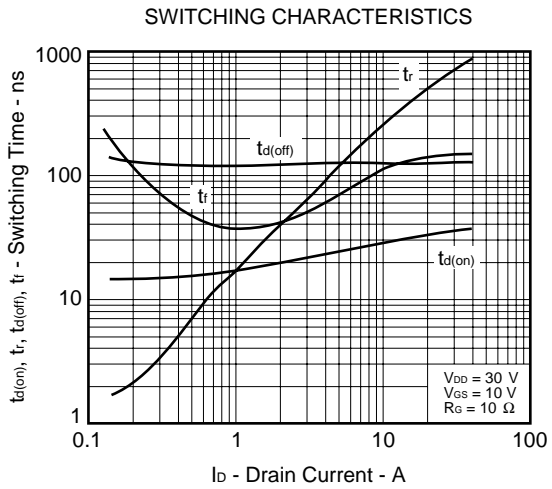
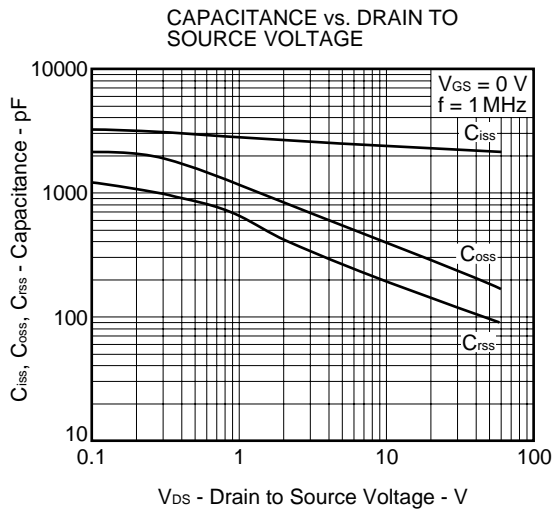
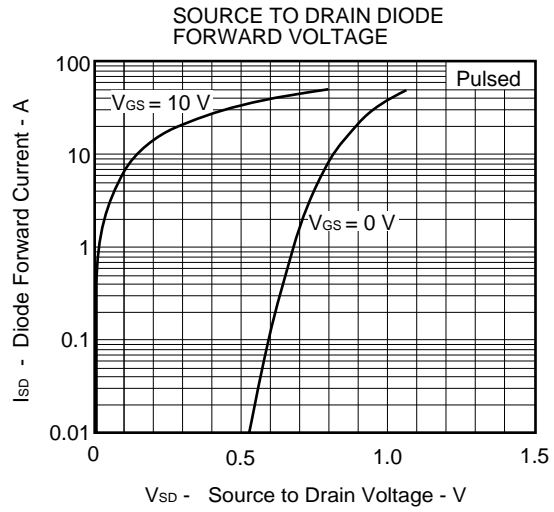
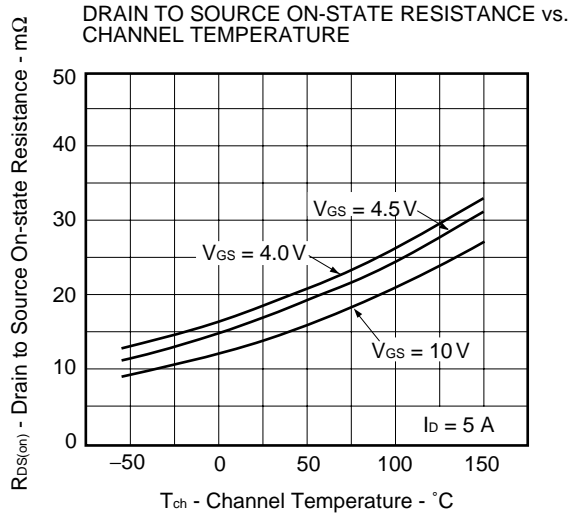


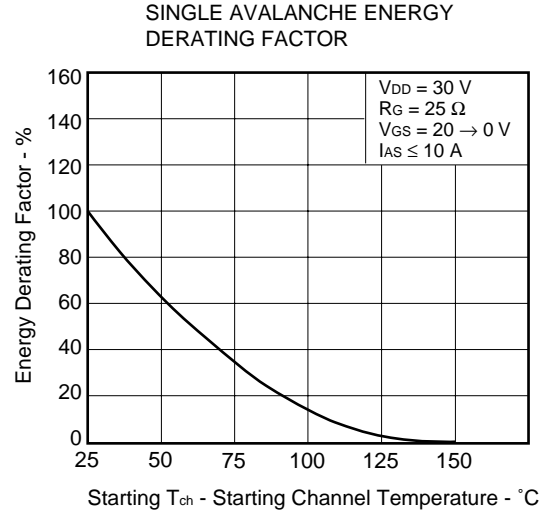
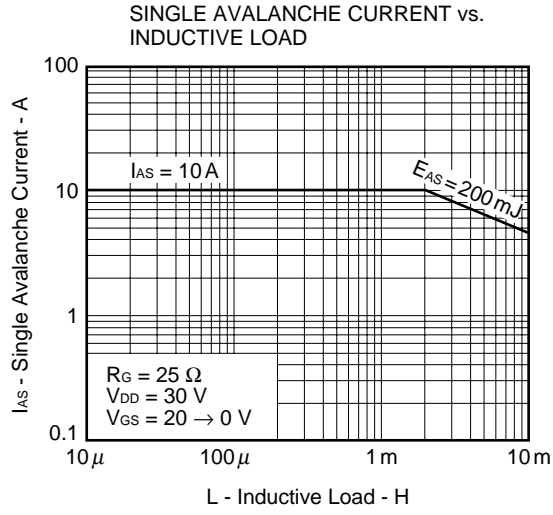
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



GATE TO SOURCE CUT-OFF VOLTAGE vs. CHANNEL TEMPERATURE







[MEMO]

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